

# **Enhancement Mode P-Channel Power MOSFET**

SOT23/PMOS/-30V/ $\pm$ 12V/-0.9V/-3.5A/65m $\Omega$ 

Rev<sub>0.5</sub>





### -30V, 65mΩ, -3.5A, P-Channel MOSFET

#### 1.Features

- Advanced Trench Technology
- ◆ Surface mount package

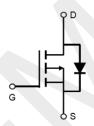
#### 2.Applications

- Power Management
- Load Switching

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SOT23 Pin Description

V <sub>DS</sub>	R <sub>DS(on)</sub> Typ.	I <sub>D</sub> .
	65mΩ @ -10V	
-30V	71mΩ @ -4.5V	-3.5A
	85mΩ @ -2.5V	



Schematic Diagram

#### 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX065P03SS	065P03	SOT23	3,000	120,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{DSS}$	-30	V
Gate to Source Voltage	$V_{GSS}$	±12	V
Drain Current (DC)	I <sub>D</sub>	-3.5	А
Drain Current (Pulse), PW≤300μs	I <sub>DP</sub>	-14	А
Total Dissipation	P <sub>D</sub>	1.2	W
Junction Temperature	Tj	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### 5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{ heta JA}$	108	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

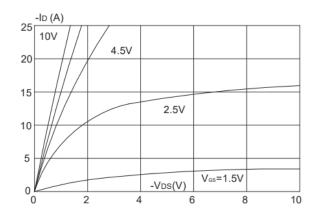
#### 6.Electrical Characteristics at Ta=25°C (Note 3)

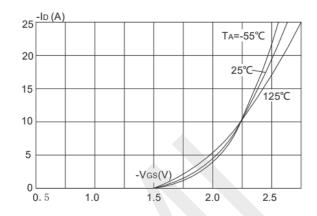
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = -250 \mu A, V_{GS} = 0V$	-30	-	-	V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -27V, V_{GS} = 0V$	-	1	-1	uA
Gate to Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	1	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =-250μA	-0.6	-0.9	-1.3	V
		I <sub>D</sub> =-2A, V <sub>GS</sub> =-10V	1	65	80	mΩ
Static Drain to Source On-State Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> =-2A, V <sub>GS</sub> =-4.5V	-	71	89	mΩ
Troologanoo		$I_D = -2A$ , $V_{GS} = -2.5V$	-	85	106	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V,	-	553	-	pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =-15V,	-	57	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	Frequency=1.0MHz	-	35	-	pF
Turn-ON Delay Time t <sub>d(or</sub>			-	10	-	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -15V, I_{D} = -3A,$	-	86	-	ns
Turn-OFF Delay Time	$t_{d(off)}$	$R_G = 2.5\Omega$ , $V_{GS} = -4.5V$	-	150	-	ns
Fall Time	t <sub>f</sub>		-	357	-	ns
	Qg	V <sub>DS</sub> = -15V,	-	6.5	-	nC
Total Gate Charge	Q <sub>gs</sub>	$V_{GS} = -4.5V$ , $I_D = -3A$	-	1.4	-	nC
	$Q_{gd}$		-	1.7	-	nC
Diode Forward Voltage	$V_{FSD}$	I <sub>S</sub> = -2A, V <sub>GS</sub> = 0	-0.4	-0.9	-1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

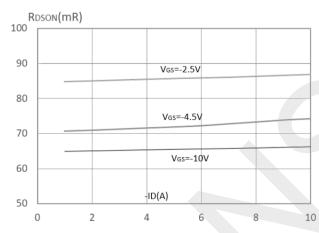


#### 7. Typical Electrical and Thermal Characteristics

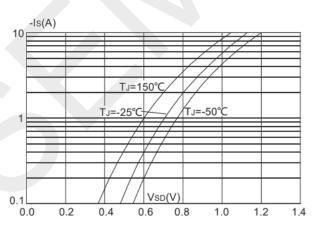




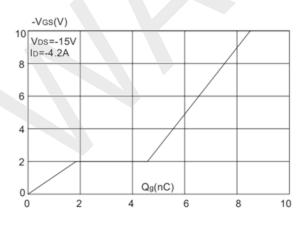
#### **Output Characteristics**



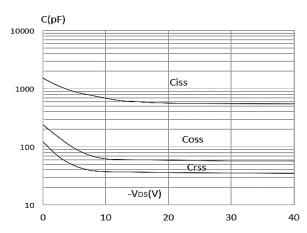
**Typical Transfer Characteristics** 



On-resistance vs. Drain Current



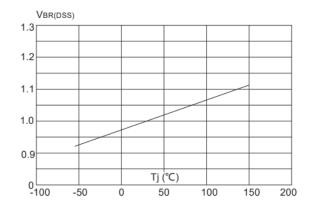
**Body Diode Characteristics** 

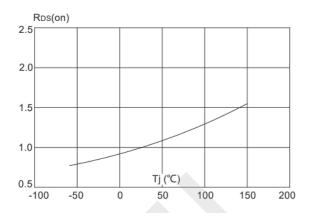


**Gate Charge Characteristics** 

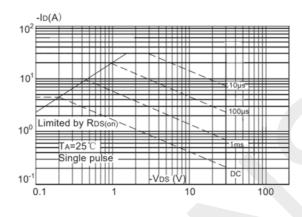
**Capacitance Characteristics** 



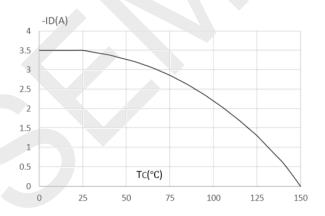




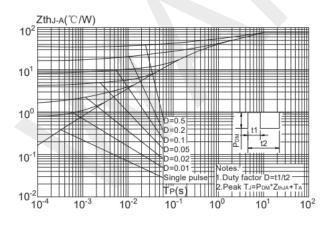
## Normalized Breakdown Voltage vs. Junction Temperature



#### Normalized on Resistance vs.Junction Temperature



**Maximum Safe Operating Area** 

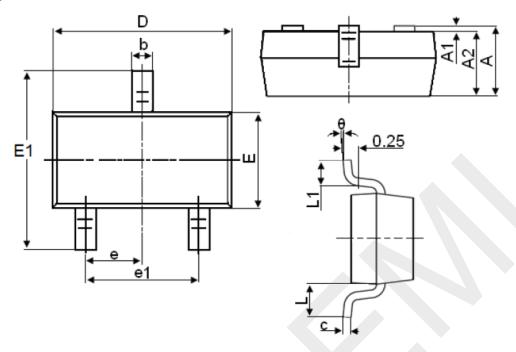


Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

Maximum Continuous Drain Current vs. Ambient Temperature



#### 8.Package Dimensions



	Dimensions in Millimeters			
Symbol	MIN.	TYP.	MAX.	
А	0.900		1.150	
A1 .	0.000		0.100	
A2	0.900		1.050	
b	0.300		0.500	
С	0.080		0.150	
D	2.800		3.000	
Е	1.200		1.400	
E1	2.250		2.550	
е		0.950		
e1	1.800		2.000	
L		0.550		
L1	0.300		0.500	
θ	0°		8°	



#### 9.Important Notice

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